

FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION**
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Sheet 1 of 1

ATTORNEY DOCKET NO.

SERIAL NO.

9319S-000636

10/762,224

APPLICANT

Hirotsuna MIURA

FILING DATE

GROUP

January 21, 2004

2853

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No
1.	GRK	2000-185392A	07/04/2000	Japan		Abstract
2.	GRK	2002-370345A	12/24/2000	Japan		Abstract

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.		

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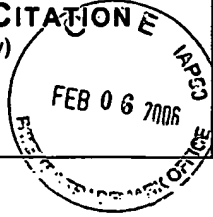
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Date Considered:

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	9319S-000636	10/762,224
	APPLICANT	
	Hirotsuna MIURA	
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FOREIGN PATENT DOCUMENTS							
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation *	
						Yes	No
1.	GRK	2002-528744	9/3/2002	Japan			X
2.	GRK	WO 00/23825	4/27/2000	PCT		X	
3.	GRK	06-071164	3/15/1994	Japan		X	
4.	GRK	2002-202414	7/19/2002	Japan		X	
5.	GRK	2001-507139	5/29/2001	Japan			X
6.	GRK	WO 98/28650	7/2/1998	PCT		X	
7.	GRK	2003-106950	4/9/2003	Japan		X	
8.	GRK	06-126955	5/10/1994	Japan		X	
9.	GRK	09-216354	8/19/1997	Japan		X	
10.	GRK	2002-131529	5/9/2002	Japan		X	
11.	GRK	2004-325944	11/18/2004	Japan		X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Ref. Desig.	Examiner's Initials	
1.		Communication from Japanese Patent Office regarding counterpart application.

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Examiner: <i>GRK</i>	Date Considered: 9/5/03
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	9319S-000636	To be assigned
	APPLICANT	
	Hirotuna MIURA	
	FILING DATE	GROUP
	Herewith	To be assigned

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation* Yes No
1.	GRK	2002-261048	9/13/2002	Japan		X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
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